

**Search Notes**

Application/Control No.

10/757,216

Examiner

Y. Lee

Applicant(s)/Patent under  
Reexamination

DE LAMEILLIEURE, JAN L.P.

Art Unit

2621

**SEARCHED**

Class	Subclass	Date	Examiner
375	240.01 240.02 240.12 240.21 240.25	7/5/2006	YL
	240.26		
	240.27		
H04N	7/12		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
375	240.25	7/5/2006	YL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR